

10/580462
IAP9 Rec'd PCT/PTO 25 MAY 2006

IN THE UNITED STATES PATENT & TRADEMARK OFFICE

Application Number : (unassigned)
Applicant : LEE, Ae-Kyoung *et al.*
Filed : May 25, 2006
Tech Cntr/AU : (unassigned)
Examiner : (unassigned)
Entitled : METHOD FOR MEASURING ELECTROMAGNETIC RADIATION PATTERN AND GAIN OF RADIATOR USING TEM WAVEGUIDE
Attorney Reference : 123037-06066007
Customer Number : 43569

MAIL STOP PCT

Commissioner for Patents
P.O. Box 1450
Alexandria, Virginia 22313-1450

INFORMATION DISCLOSURE STATEMENT UNDER 37 C.F.R. §1.97

Sir:

Pursuant to 37 CFR §1.97 and 1.56, the attention of the U.S. Patent and Trademark Office is hereby directed to the following disclosures made herein, which include:

REFERENCES AND RELEVANCY

- Applicant(s) wish(es) to make of record the documents listed on the attached Form PTO-1449. Copies of the listed documents are attached, where required, as are any readily available full or partial English translations of any non-English language documents.
- Applicant(s) wish(es) to make of record the documents listed on the attached Form PTO-1449. The references cited herein were cited for consideration in the parent application, and, pursuant to 37 CFR 1.98(d), copies of the cited references can be found in the file of the parent application (U.S. Serial No. , filed).
- Applicant(s) wish(es) to make of record the documents listed on the attached Form PTO-1449. The references cited herein were cited in the International Search Report issued for the corresponding International application, and copies of the International Search Report and the cited references are attached for the Examiner's consideration.
- Applicant(s) wish(es) to make of record the documents listed on the attached Form PTO-1449. The references cited herein were cited in a communication from a foreign or international patent office in a counterpart foreign or international application(s), and copies of both the relevant communication and the cited references, where required, are attached for the Examiner's consideration.

CERTIFICATION

The undersigned certifies that, pursuant to 37 CFR §1.97(e)(1),

- each item of information contained in this Information Disclosure Statement was cited in a communication from a foreign or international patent office in a counterpart foreign or international application not more than three months prior to the filing of this Statement.

RELATED CASES

- Identified in the attached Appendix are related applications directed to related technical subject matter. Copies of the related applications, where required, are attached for the Examiner's consideration. *The identification of the related U.S. patent applications is not to be construed as a waiver of secrecy for those applications, now or upon issuance of the present application as a patent.*

BASIS FOR CONSIDERATION

This Information Disclosure Statement is filed:

- within three months of the filing date of the application and/or before the mailing date of a first Official Action on the merits, and no fee is required [37 C.F.R. §1.97(b)].
- with the appropriate certification, and no fee is required [37 C.F.R. §1.97(e)(1)].
- after the mailing date of the first Official Action on the merits, but prior to the issuance of a Notice of Allowance, and the requisite fee is authorized herein for payment [37 C.F.R. §1.97(c)].
- after the mailing date of the Notice of Allowance, but prior to the payment of the issue fee, the requisite certification under 37 CFR §1.97(e)(1) is made herein, and the requisite fee is authorized herein for payment [37 C.F.R. §1.97(d)].
- with a Request for Continued Examination (RCE), and no fee is required [37 C.F.R. §1.97(b)(4)].

FEE AUTHORIZATION

- Authorization is hereby given to charge any deficient fee(s) under 37 CFR §1.16 and §1.17 as necessary to ensure the consideration of this disclosure, or to credit any fee overpayments, to Deposit Account No. 503-121.
- Authorization is hereby given to charge the requisite fee of \$180 (Fee Code 1806) for submission of this Information Disclosure Statement to Deposit Account No. 503-121.

It is respectfully requested that this information be expressly considered during the prosecution of this application, and that the reference(s) be made of record therein and appear among the "References Cited" on any patent to issue therefrom.

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Information Disclosure Statement
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The Examiner is further respectfully requested to return of a copy of the enclosed Form PTO-1449 with the Examiner's initials in the left column.

The examination and allowance of this Application is respectfully requested.

Respectfully Submitted,

MAYER BROWN ROWE & MAW LLP

By: 
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Date: May 25, 2006

Attachment(s): PTO Form 1449
International Search Report
Cited References

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FORM PTO-1449 (modified)

IAPU RECEIVED/FILED 25 MAY 2006

U.S. Department of Commerce
U.S. Patent & Trademark OfficeINFORMATION DISCLOSURE STATEMENT
BY APPLICANT

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Examiner: unassigned

Group Art Unit: unassigned

U.S. PATENT DOCUMENTS

Examiner's Initials*		Document Number	Date MM/DD/YYYY	Name (Family Name of First Inventor)	Class	Sub Class	Filing Date (if appropriate)
	AR	5,404,098	04/04/1995	Osburn	G01R	27/02	08/14/1992
	BR	6,181,285	01/30/2001	Sullivan et al.	G01R	29/08	05/24/2000
	CR	5,237,283	08/17/1993	Carbonini	G01R	29/08	06/10/1992
	DR						
	ER						
	FR						

FOREIGN PATENT DOCUMENTS

		Document Number	Date MM/DD/YYYY	Country	Translation Readily Available		English Abstract	
					Enclosed	No	Enclosed	No
	GR	1020030056277	07/03/2003	Republic of Korea		X	X	
	HR	1020030002957	01/09/2003	Republic of Korea		X	X	
	IR	JP 2003-057281	02/26/2003	Japan		X	X	
	JR							
	KR							
	LR							
	MR							

OTHER (Including in this order Author, Title, Periodical Name, Date, Pertinent Pages, etc.)

	NR	P. Wilson; "On Correlating TEM Cell and OATS Emission Measurements"; IEEE Transactions on Electromagnetic Compatibility; Vol. 37; No. 1; February 1995; pp. 1-16.
	OR	"American National Standard for Methods of Measurement of Radio-Noise emissions from Low-Voltage Electrical and Electronic Equipment in the Range of 9kHz to 40GHz"; ANSI C63.4-2001; pp.114-123.
	PR	A.K. Lee; "A SIMPLE METHOD FOR DETERMINATION OF EFFECTIVE RADIATED POWER FROM A HANDSET"; BEMS Twenty-Fifth Annual Meeting held on June 22-27, 2003; pp. 1-15.
	QR	International Search Report dated September 30, 2004 for PCT/KR2004/001509.
	RR	
	SR	

Examiner

Date Considered:

*EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP § 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.